

UD info Corp.

Industrial SATA Solid State Drive M18-16UK Series Product DataSheet



UD info CORP.

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Revision History

Revision	Draft Date	History	Author
1.0	2018/3/22	New release	Golden Lee
1.1	2018/7/23	Update performance and power consumption	Golden Lee
1.2	2019/1/28	Add 3D Bics3 support	Golden Lee
1.3	2019/8/5	Add 3D Bics3 pSLC support	Golden Lee



Product Overview

- **Capacity**
 - MLC: 32GB up to 512GB
 - pSLC: 16GB up to 256GB
 - SLC: 8GB up to 128GB
 - 3D Bics3: 64GB up to 1TB
 - Bics3 pSLC: 16GB up to 256GB
- **SATA Interface**
 - SATA Revision 3.2
 - SATA 1.5Gbps, 3Gbps, and 6Gbps interface
- **Flash Interface**
 - Flash Type: MLC, 3D Bics3 TLC, SLC
- **Performance**
 - Read up to 550 MB/s
 - Write up to 470 MB/s
- **Power Consumption^{Note1}**
 - Active mode: < 2,550 mW
 - Idle mode: < 310 mW
- **TBW (Terabyte Written)^{Note2}**
 - MLC: 540 TBW for 512GB
 - pSLC: 1,510 TBW for 256GB
 - SLC: 2,133 TBW for 128GB
 - 3D Bics3: 835 TBW for 1TB
 - Bics3 pSLC: 12,196 TBW for 256GB
- **MTBF**
 - MLC/3D Bics3: 2,000,000 hours
 - pSLC: 2,500,000 hours
 - SLC: 3,000,000 hours
- **Advanced Flash Management**
 - Static and Dynamic Wear Leveling
 - Bad Block Management
 - TRIM
 - SMART
 - Over-Provision
- **Low Power Management**
 - DIPM/HIPM Mode
 - DEVSLP Mode (Optional)
- **Temperature Range**
 - Operation (Standard): 0°C ~ 70°C
 - Operation (Wide): -40°C ~ 85°C
 - Storage: -40°C ~ 85°C
- **Compliant**
 - RoHS
 - CE & FCC

Notes:

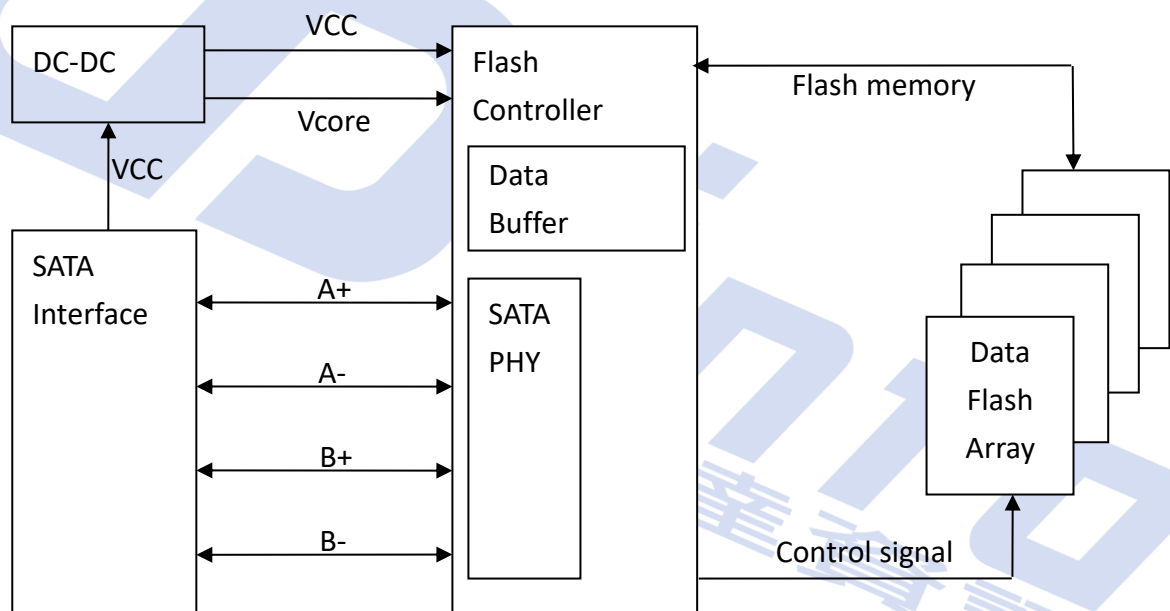
1. Please see “Power Consumption” for details.
2. Please see “TBW (Terabytes Written)” in chapter 2 for details.

1. INTRODUCTION

1.1. General Description

UDinfo 1.8" SATA SSD delivers all the advantages of Flash Disk technology with Serial ATA III interface, including being fully compliant with standard 1.8-inch form factor, providing low power consumption compared to traditional hard drive and hot-swapping when removing/replacing/upgrading flash disks. The device is designed based on the standard 7-pin interface for data segment and 9-pin for power segment, as well as operating at a maximum operating frequency of 200MHz with 30MHz external crystal. Its capacity could provide a wide range up to 1TB. Moreover, it can reach up to 550MB/s read as well as 470MB/s write high performance based on Toshiba's NAND flash (with 32MB SDR cache enabled and measured by CrystalDiskMark v5.0).

1.2. Block Diagram



1.8" SATA SSD Block Diagram

2. PRODUCT SPECIFICATIONS



- **Capacity**
 - MLC: From 32GB up to 512GB (support 48-bit addressing mode)
 - pSLC: From 16GB up to 256GB (support 48-bit addressing mode)
 - SLC: From 8GB up to 128GB (support 48-bit addressing mode)
 - 3D Bics3: From 64GB up to 1TB (support 48-bit addressing mode)
 - Bics3 pSLC: From 16GB up to 256GB (support 48-bit addressing mode)
- **Electrical/Physical Interface**
 - SATA Interface
 - ◆ Compliant with SATA Revision 3.2
 - ◆ Compatible with SATA 1.5Gbps, 3Gbps and 6Gbps interface
 - ◆ Support power management
 - ◆ Support expanded register for SATA protocol 48 bits addressing mode
 - ◆ Embedded BIST function for SATA PHY for low cost mass production
- **Built-in 2-channel NAND flash interface controller**
 - Compliant with Toggle 1.0 and Toggle 2.0 NAND Flash interface
 - Compliant with ONFI 4.0 interface:
 - ◆ SDR up to mode 5
 - ◆ NV-DDR up to mode 5
 - ◆ NV-DDR2 up to mode 7
 - ◆ NV-DDR3 up to mode 8
- **Supported NAND Flash**
 - Support up to 16 Flash Chip Enables (CE) within single design
 - Toshiba 15nm/3D-NAND MLC and TLC
 - Support all types of SLC/MLC/TLC/3D-NAND, 8KB/page and 16K/page NAND flash
- **ECC Scheme**
 - Applies the LDPC (Low Density Parity Check) of ECC algorithm
- **UART function**
- **GPIO**
- **Support SMART and TRIM commands**

- Capacity Information

Capacity	Cylinders	Heads	Sectors	Total Sectors	User Data Size
8GB	15,525	16	63	15,649,200	Depended on file management
16GB	16,383	16	63	31,277,232	
30GB	16,383	16	63	58,626,288	
32GB	16,383	16	63	62,533,296	
60GB	16,383	16	63	117,231,408	
64GB	16,383	16	63	125,045,424	
120GB	16,383	16	63	234,441,648	
128GB	16,383	16	63	250,069,680	
240GB	16,383	16	63	468,862,128	
256GB	16,383	16	63	500,118,192	
480GB	16,383	16	63	937,703,088	
512GB	16,383	16	63	1,000,215,216	
960GB	16,383	16	63	1,875,385,008	
1TB	16,383	16	63	2,000,409,264	

- Performance

- MLC:

Capacity	Flash Structure	Flash Type	Sequential	
			Read (MB/s)	Write (MB/s)
32GB	32GB x 1	15nm, BGA	350	160
64GB	32GB x 2	15nm, BGA	550	320
	64GB x 1	15nm, BGA	350	260
128GB	64GB x 2	15nm, BGA	550	450
256GB	64GB x 4	15nm, BGA	550	470
	128GB x 2	15nm, BGA	550	450
512GB	128GB x 4	15nm, BGA	550	470
	256GB x 2	15nm, BGA	550	470

■ pSLC:

Capacity	Flash Structure	Flash Type	Sequential	
			Read (MB/s)	Write (MB/s)
16GB	32GB x 1	15nm, BGA	350	160
32GB	32GB x 2	15nm, BGA	550	320
	64GB x1	15nm, BGA	350	260
64GB	64GB x 2	15nm, BGA	550	450
128GB	64GB x 4	15nm, BGA	550	470
	128GB x 2	15nm, BGA	550	450
256GB	128GB x 4	15nm, BGA	550	470
	256GB x 2	15nm, BGA	550	470

■ SLC:

Capacity	Flash Structure	Flash Type	Sequential	
			Read (MB/s)	Write (MB/s)
8GB	8GB x 1	24nm, BGA	320	70
16GB	8GB x 2	24nm, BGA	540	150
32GB	16GB x 2	24nm, BGA	510	300
64GB	32GB x 2	24nm, BGA	510	310
128GB	32GB x 4	24nm, BGA	470	420

■ 3D Bics3:

Capacity	Flash Structure	Flash Type	Sequential	
			Read (MB/s)	Write (MB/s)
64GB	64GB x 1	TSB Bics3, BGA	320	220
128GB	64GB x 2	TSB Bics3, BGA	550	450
256GB	128GB x 2	TSB Bics3, BGA	550	460
512GB	128GB x 4	TSB Bics3, BGA	520	470
	256GB x 2	TSB Bics3, BGA	550	470
1TB	256GB x 4	TSB Bics3, BGA	530	470

■ Bics3 pSLC:

Capacity	Flash Structure	Flash Type	Sequential	
			Read (MB/s)	Write (MB/s)
16GB	64GB x 1	TSB Bics3, BGA	320	190
32GB	64GB x 2	TSB Bics3, BGA	550	380
64GB	128GB x 2	TSB Bics3, BGA	550	460
128GB	256GB x 2	TSB Bics3, BGA	550	470
256GB	256GB x 4	TSB Bics3, BGA	530	470

Notes:

1. The performance was estimated based on Toshiba NAND flash.
2. Performance may differ according to flash configuration and platform.
3. The table above is for reference only.

- **TBW (Terabytes Written)**

- **MLC:**

Capacity	Flash Structure	TBW
32GB	16GB x 2	13
64GB	64GB x1	30
128GB	64GB x 2	87
256GB	64GB x 4	198
512GB	128GB x 4	540

- **pSLC:**

Capacity	Flash Structure	TBW
16GB	16GB x 2	49
32GB	64GB x1	106
64GB	64GB x 2	215
128GB	64GB x 4	649
256GB	128GB x 4	1510

- **SLC:**

Capacity	Flash Structure	TBW
8GB	8GB x 1	74
16GB	8GB x 2	153
32GB	16GB x 2	325
64GB	32GB x 2	761
128GB	32GB x 4	2133

■ 3D Bics3:

Capacity	Flash Structure	TBW
64GB	64GB x 1	42
128GB	64GB x 2	75
256GB	128GB x 2	180
512GB	256GB x 2	425
1TB	256GB x 4	835

■ Bics3 pSLC:

Capacity	Flash Structure	TBW
16GB	64GB x 1	374
32GB	64GB x 2	769
64GB	128GB x 2	1682
128GB	256GB x 2	5034
256GB	256GB x 4	12196

Notes:

1. Samples were built using Toshiba NAND flash.
2. The test followed JEDEC219A client endurance workload.
3. TBW may differ according to flash configuration and platform.
4. The endurance of SSD could be estimated based on user behavior, NAND endurance cycles, and write amplification factor. It is not guaranteed by flash vendor.

3. ENVIRONMENTAL SPECIFICATIONS



3.1. Environmental Conditions

3.1.1. Temperature and Humidity

- Temperature:
 - ◆ Storage: -40°C to 85°C
 - ◆ Operational (Standard grade): 0°C to 70°C
 - ◆ Operational (Wide grade): -40°C to 85°C
- Humidity:
 - ◆ Standard grade: RH 90% under 40°C (operational)
 - ◆ Wide grade: RH 95% under 55°C (operational)

■ High Temperature Test Condition

	Temperature	Humidity
Operation (Standard)	70°C	0% RH
Operation (Wide)	85°C	0% RH
Storage (Standard)	85°C	0% RH
Storage (Wide)	85°C	0% RH

Result: No any abnormality is detected.

■ Low Temperature Test Condition

	Temperature	Humidity
Operation (Standard)	0°C	0% RH
Operation (Wide)	-40°C	0% RH
Storage (Standard)	-40°C	0% RH
Storage (Wide)	-40°C	0% RH

Result: No any abnormality is detected.

■ High Humidity Test Condition

	Temperature	Humidity
Operation (Standard)	40°C	93% RH
Operation (Wide)	55°C	95% RH
Storage (Standard)	40°C	95% RH
Storage (Wide)	55°C	95% RH

Result: No any abnormality is detected.

■ Temperature Cycle Test

	Temperature	Test Time
Operation (Standard)	0°C	30 min
	70°C	30 min
Operation (Wide)	-40°C	30 min
	85°C	30 min
Storage (Standard)	-40°C	30 min
	85°C	30 min
Storage (Wide)	-40°C	30 min
	85°C	30 min

Result: No any abnormality is detected.

3.1.2. Shock

■ Shock Specification

	Acceleration Force	Half Sin Pulse Duration
Non-Operational	1500G	0.5ms
Operational	1500G	0.5ms

Result: No any abnormality is detected when power on.

3.1.3. Vibration

■ Vibration Specification

	Condition		Vibration Orientation
	Frequency/Displacement	Frequency/Acceleration	
Operational	20Hz~80Hz/1.52mm	80Hz~2000Hz/20G	X, Y, Z axis/60 min for each

Result: No any abnormality is detected when power on.

3.1.4. Drop

■ Drop Specification

	Height of Drop	Number of Drop
Non-operational	80cm free fall	6 face of each unit, 2 times each

Result: No any abnormality is detected when power on.

3.1.5. Bending

■ Bending Specification

	Force	Action
Non-operational	≥ 20N	Hold 1min/5times

Result: No any abnormality is detected when power on.

3.1.6. Torque

■ Torque Specification

	Force	Action
Non-operational	1.263N-m or ± 10 deg	Hold 1min/5times

Result: No any abnormality is detected when power on.

3.1.7. Electrostatic Discharge (ESD)

■ Contact ESD Specification

Device	Capacity	Temperature	Relative Humidity	+/- 4KV	Result
1.8" SSD	256GB	24.0°C	49% (RH)	Device functions are affected, but EUT will be back to its normal or operational state automatically.	PASS
	512GB				

3.2. MTBF

MTBF, an acronym for Mean Time between Failures, is a measure of a device's reliability. Its value represents the average time between a repair and the next failure. The measure is typically in units of hours. The higher the MTBF value, the higher the reliability of the device. The predicted result of UDinfo's 1.8" SATA SSD is up to 3,000,000 hours.

3.3. Certification

- RoHS
- CE / FCC

3.4. Compliance

- SATA III (SATA Rev. 3.2)
- Up to ATA/ATAPI-8 (Including S.M.A.R.T)

4. ELECTRICAL SPECIFICATIONS



4.1. Supply Voltage

Parameter	Rating
Operating Voltage	3.3V +/- 5% (Default)
	5V +/- 5% (Option)

4.2. Power Consumption

■ MLC

Capacity	Flash Structure	Flash Type	Read	Write	Idle
32GB	32GB x 1	15nm, BGA	980	980	310
64GB	32GB x 2	15nm, BGA	1,310	1,330	310
	64GB x 1	15nm, BGA	1,130	1,150	310
128GB	64GB x 2	15nm, BGA	1,510	1,580	310
256GB	64GB x 4	15nm, BGA	2,410	2,550	310
	128GB x 2	15nm, BGA	1,555	1,645	310
512GB	128GB x 4	15nm, BGA	2,355	2,550	310
	256GB x 2	15nm, BGA	1,770	1,630	310

Unit: mW

■ pSLC

Capacity	Flash Structure	Flash Type	Read	Write	Idle
16GB	32GB x 1	15nm, BGA	980	985	310
32GB	32GB x 2	15nm, BGA	1,310	1,330	310
	64GB x 1	15nm, BGA	1,110	1,150	310
64GB	64GB x 2	15nm, BGA	1,500	1,585	310
128GB	64GB x 4	15nm, BGA	1,620	1,760	310
	128GB x 2	15nm, BGA	1,540	1,650	310
256GB	128GB x 4	15nm, BGA	1,670	1,790	310
	256GB x 2	15nm, BGA	1,650	1,660	310

Unit: mW

■ SLC

Capacity	Flash Structure	Flash Type	Read	Write	Idle
8GB	8GB x 1	24nm, BGA	850	860	310
16GB	8GB x 2	24nm, BGA	1,120	1,125	310
32GB	16GB x 2	24nm, BGA	1,640	1,650	310
64GB	32GB x 2	24nm, BGA	1,700	1,730	310
128GB	32GB x 4	24nm, BGA	2,110	2,230	310

Unit: mW

■ 3D Bics3

Capacity	Flash Structure	Flash Type	Read	Write	Idle
64GB	64GB x 1	TSB Bics3, BGA	900	900	310
128GB	64GB x 2	TSB Bics3, BGA	1360	1350	310
256GB	128GB x 2	TSB Bics3, BGA	1430	1420	310
512GB	128GB x 4	TSB Bics3, BGA	1820	1810	310
	256GB x 2	TSB Bics3, BGA	1700	1690	310
1TB	256GB x 4	TSB Bics3, BGA	1900	1900	310

Unit: mW

■ Bics3 pSLC

Capacity	Flash Structure	Flash Type	Read	Write	Idle
16GB	64GB x 1	TSB Bics3, BGA	985	1000	310
32GB	64GB x 2	TSB Bics3, BGA	1150	1210	310
64GB	128GB x 2	TSB Bics3, BGA	1300	1310	310
128GB	256GB x 2	TSB Bics3, BGA	1320	1400	310
256GB	256GB x 4	TSB Bics3, BGA	1900	1900	310

Unit: mW

Notes:

1. It's average value of power consumption is achieved based on 100% conversion efficiency.
2. The measured power voltage is 3.3V.
3. Samples were built using Toshiba NAND flash and measured under normal temperature.
4. Sequential R/W is measured while testing 4000MB sequential R/W 5 times by CrystalDiskMark.
5. Power Consumption may differ according to flash configuration and platform.

5. INTERFACE



5.1. Pin Assignment and Descriptions

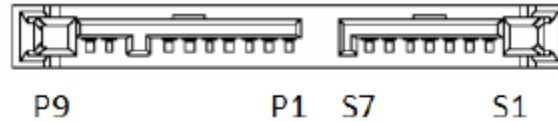


Table 5-1 Signal Segment Pin Assignment and Descriptions

Pin Number	Function
S1	GND
S2	A+ (Differential Signal Pair A)
S3	A – (Differential Signal Pair A)
S4	GND
S5	B – (Differential Signal Pair B)
S6	B+ (Differential Signal Pair B)
S7	GND

Table 5-2 Power Segment Pin Assignment and Descriptions

Pin Number	Type	Function
P1	V ₃₃	3.3V Power Input
P2	V ₃₃	3.3V Power Input
P3	GND	GND
P4	GND	GND
P5	V ₅	Reserved for 5V Power Input (Option)
P6	V ₅	Reserved for 5V Power Input (Option)
P7	Optional	Reserved for Active LED (Option)
Key	Key	N/C
P8	Optional	Erase function (Option)
P9	Optional	Reserved (Not Connected)

6. SUPPORTED COMMANDS



6.1. ATA Command List

Op-Code	Command Description	Op-Code	Command Description		
00h	NOP	60h	Read FPDMA Queued		
06h	Data Set Management	61h	Write FPDMA Queued		
10h	Recalibrate	70h	Seek		
20h	Read Sectors	90h	Execute Device Diagnostic		
21h	Read Sectors without Retry	91h	Initialize Device Parameters		
24h	Read Sectors EXT	92h	Download Microcode		
25h	Read DMA EXT	93h	Download Microcode DMA		
27h	Read Native Max Address EXT	B0h	SMART		
29h	Read Multiple EXT	B0h	D0h	SMART READ DATA	
2Fh	Read Log EXT	B0h	D1h	SMART READ DATA ATTRIBUTE THRESHOLD	
30h	Write Sectors	B0h	D2h	SMART ENABLE/DISABLE ATTRIBUTE AUTOSAVE	
31h	Write Sectors without Retry	B0h	D3h	SMART SAVE ATTRIBUTE VALUES	
34h	Write Sectors EXT	B0h	D4h	SMART EXECUTE OFF-LINE IMMEDIATE	
35h	Write DMA EXT	B0h	D5h	SMART READ LOG	
37h	Set Native Max Address EXT	B0h	D6h	SMART WRITE LOG	
39h	Write Multiple EXT	B0h	D8h	SMART ENABLE OPERATIONS	
3Dh	Write DMA FUA EXT	B0h	D9h	SMART DISABLE OPERATIONS	
3Fh	Write Long EXT	B0h	DAh	SMART RETURN STATUS	
40h	Read Verify Sectors	B0h	DBh	SMART ENABLE/DISABLE AUTOMATIC OFF-LINE	
41h	Read Verify Sectors without Retry	B1h		DEVICE CONFIGURATION OVERLAY	
42h	Read Verify Sectors EXT	B1h	C0h	DEVICE CONFIGURATION RESTORE	
45h	Write Uncorrectable EXT	B1h	C1h	DEVICE CONFIGURATION FREEZE LOCK	
47h	Read Log DMA EXT	B1h	C2h	DEVICE CONFIGURATION IDENTIFY	
57h	Write Log DMA EXT	B1h	C3h	DEVICE CONFIGURATION SET	
B1h	C4h	DEVICE CONFIGURATION IDENTIFY DMA		ECh	Identify Device
B1h	C5h	DEVICE CONFIGURATION SET DMA		EFh	Set Features
C4h	Read Multiple	EFh	02h	Enable 8-bit PIO transfer mode	

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Op-Code		Command Description	Op-Code		Command Description
C5h		Write Multiple	EFh	03h	Set transfer mode based on value in Count field
C6h		Set Multiple Mode	EFh	05h	Enable advanced power management
C8h		Read DMA	EFh	10h	Enable use of Serial ATA feature
C9h		Read DMA without Retry	EFh	10h 02h	Enable DMA Setup FIS Auto-Activate optimization
CAh		Write DMA	EFh	10h 03h	Enable Device-initiated interface power state (DIPM) transitions
CBh		Write DMA without Retry	EFh	10h 06h	Enable Software Settings Preservation (SSP)
CEh		Write Multiple FUA EXT	EFh	10h 07h	Enable Device Automatic Partial to Slumber transitions
E0h		Standby Immediate	EFh	10h 09h	Enable Device Sleep
E1h		Idle Immediate	EFh	55h	Disable read look-ahead feature
E2h		Standby	EFh	66h	Disable reverting to power-on defaults
E3h		Idle	EFh	82h	Disable write cache
E4h		Read Buffer	EFh	85h	Disable advanced power management
E5h		Check Power Mode	EFh	90h	Disable use of Serial ATA feature set
E6h		Sleep	EFh	90h 02h	Disable DMA Setup FIS Auto-Activate optimization
E7h		Flush Cache	EFh	90h 03h	Disable Device-initiated interface power state (DIPM) transitions
E8h		Write Buffer	EFh	90h 06h	Disable Software Settings Preservation (SSP)
E9h		Read Buffer DMA	EFh	90h 07h	Disable Device Automatic Partial to Slumber transitions
EAh		Flush Cache EXT	EFh	90h 09h	Disable Device Sleep
EBh		Write Buffer DMA	EFh	AAh	Enable read look-ahead feature
EFh	CCh	Enable reverting to power-on defaults	F4h		Security Erase Unit
F1h		Security Set Password	F5h		Security Freeze Lock
F2h		Security Unlock	F6h		Security Disable Password
F3h		Security Erase Prepare	F8h		Read Native Max Address

6.2. Identify Device Data

The following table details the sector data returned by the IDENTIFY DEVICE command.

Word	F: Fixed V: Variable X: Both	Default Value	Description
0	F	0040h	General configuration bit-significant information
1	X	*1	Obsolete – Number of logical cylinders
2	V	C837h	Specific configuration
3	X	0010h	Obsolete – Number of logical heads (16)
4-5	X	00000000h	Retired
6	X	003Fh	Obsolete – Number of logical sectors per logical track (63)
7-8	V	00000000h	Reserved for assignment by the Compact Flash Association
9	X	0000h	Retired
10-19	F	Varies	Serial number (20 ASCII characters)
20-21	X	0000h	Retired
22	X	0000h	Obsolete
23-26	F	Varies	Firmware revision (8 ASCII characters)
27-46	F	Varies	Model number (xxxxxxxx)
47	F	8010h	7:0- Maximum number of sectors transferred per interrupt on MULTIPLE commands
48	F	4000h	Reserved
49	F	2F00h	Capabilities
50	F	4000h	Capabilities
51-52	X	00000000h	Obsolete
53	F	0007h	Words 88 and 70:64 valid
54	X	*1	Obsolete – Number of logical cylinders
55	X	0010h	Obsolete – Number of logical heads (16)
56	X	003Fh	Obsolete – Number of logical sectors per track (63)
57-58	X	*2	Obsolete – Current capacity in sectors
59	F	0110h	Number of sectors transferred per interrupt on MULTIPLE commands
60-61	F	*3	Maximum number of sector (28bit LBA mode)
62	X	0000h	Obsolete
63	F	0407h	Multi-word DMA modes supported/selected
64	F	0003h	PIO modes supported
65	F	0078h	Minimum Multiword DMA transfer cycle time per word

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Word	F: Fixed V: Variable X: Both	Default Value	Description
66	F	0078h	Manufacturer's recommended Multiword DMA transfer cycle time
67	F	0078h	Minimum PIO transfer cycle time without flow control
68	F	0078h	Minimum PIO transfer cycle time with IORDY flow control
69	F	5F20h	Additional Supported
70	F	0000h	Reserved
71-74	F	0000000000000000 0h	Reserved for the IDENTIFY PACKET DEVICE command
75	F	001Fh	Queue depth
76	F	E70Eh	Serial SATA capabilities
77	F	0006/0004/0002h	Supported Serial ATA Phy speed
78	F	054Ch	Serial ATA features supported
79	V	0040H	Serial ATA features enabled
80	F	03F8h	Major Version Number
81	F	0000h	Minor Version Number
82	F	746Bh	Command set supported
83	F	7D09h	Command set supported
84	F	4163h	Command set/feature supported extension
85	V	7469h	Command set/feature supported or enabled
86	V	BC09h	Command set/feature supported or enabled
87	V	4163h	Command set/feature supported or enabled
88	V	007Fh	Ultra DMA Modes
89	F	0001h	Time required for Normal Erase mode SECURITY ERASE UNIT command
90	F	0001h	Time required for an Enhanced Erase mode SECURITY ERASE UNIT command
91	V	00FEh	Current advanced power management value
92	V	FFFEh	Master Password Revision Code
93	F	0000h	Hardware reset result. The contents of the bits (12:0) of this word can be changed only during the execution of hardware reset.
94	V	0000h	Vendor's recommended and actual acoustic management value
95	F	0000h	Stream Minimum Request Size

Word	F: Fixed V: Variable X: Both	Default Value	Description
96	V	0000h	Streaming Transfer Time – DMA
97	V	0000h	Streaming Access Latency – DMA and PIO
98-99	F	0000h	Streaming Performance Granularity
100-103	V	*4	Maximum user LBA for 48 bit Address feature set
104	V	0000h	Streaming Transfer Time – PIO
105	F	0008h	Maximum number of 512-byte blocks per DATA SET MANAGEMENT command
106	F	4000h	Physical sector size/Logical sector size
107	F	0000h	Inter-seek delay for ISO-7779 acoustic testing in microseconds
108-111	F	0000000000000000 0h	Unique ID
112-115	F	0000000000000000 0h	Reserved
116	V	0000h	Reserved
117-118	F	00000000h	Words per logical Sector
119	F	401Ch	Supported settings
120	F	401Ch	Command set/Feature Enabled/Supported
121-126	F	0h	Reserved
127	F	0h	Removable Media Status Notification feature set support
128	V	0021h	Security status
129-159	X	0h	Vendor specific
160	F	0h	Compact Flash Association (CFA) power mode 1
161-167	X	0h	Reserved for assignment by the CFA
168	F	3h 2.5 inch 4h 1.8 inch 5h Less than 1.8 inch	Device Nominal Form Factor
169	F	0001h	DATA SET MANAGEMENT command is supported
170-173	F	0h	Additional Product Identifier
174-175		0h	Reserve
176-205	V	0h	Current media serial number
206	F	0039h	SCT Command Transport(
207-208	F	0h	Reserved
209	F	4000h	Alignment of logical blocks within a physical block

Word	F: Fixed V: Variable X: Both	Default Value	Description
210-211	V	0000h	Write-Read-Verify Sector Count Mode 3 (not support)
212-213	F	0000h	Write-Read-Verify Sector Count Mode 2 (not support)
214-216		0000h	NV Cache relate (not support)
217	F	0001h	Non-rotating media device
218	F	0h	Reserved
219	F	0h	NV Cache relate (not support)
220	V	0h	Write read verify feature set current mode
221		0h	Reserved
222	F	107Fh	Transport major version number
223	F	0h	Transport minor version number
224-229		0h	reserved
230-233		0h	Extend number of user addressable sectors
234		0001h	Minimum number of 512-byte data blocks per DOWNLOAD MICROCODE command for mode 03h
235		FFFFh	Maximum number of 512-byte data blocks per DOWNLOAD MICROCODE command for mode 03h
236-242	F	0h	Reserved
243		4000h	Security feature 4000 : Self Encrypting Drive
244-254	F	0h	Reserved
255	X	XXA5h XX is variable	Integrity word (Checksum and Signature)

■ List of Device Identification for Each Capacity

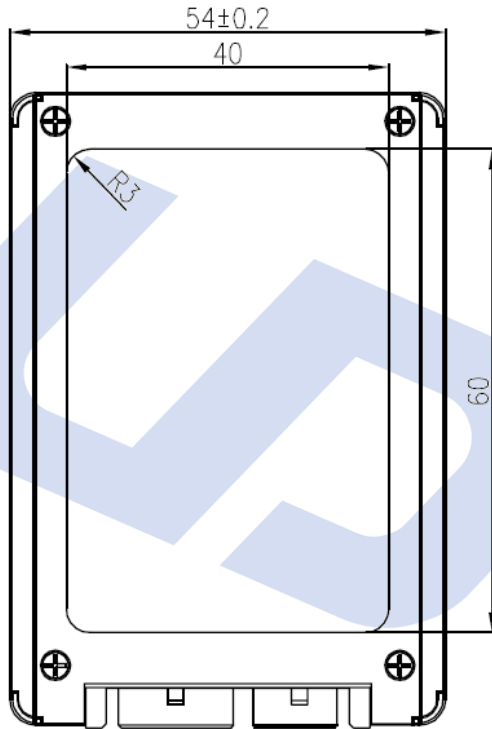
Capacity (GB)	*1 (Word 1/Word 54)	*2 (Word 57–58)	*3 (Word 60–61)	*4 (Word 100–103)
8	3CA5h	EEC9B0h	EEC9B0h	EEC9B0h
16	3FFFh	FBFC10h	1DD40B0h	1DD40B0h
30	3FFFh	FBFC10h	37E90F0h	37E90F0h
32	3FFFh	FBFC10h	3BA2EB0h	3BA2EB0h
60	3FFFh	FBFC10h	6FCCF30h	6FCCF30h
64	3FFFh	FBFC10h	7740AB0h	7740AB0h
120	3FFFh	FBFC10h	DF94BB0h	DF94BB0h
128	3FFFh	FBFC10h	EE7C2B0h	EE7C2B0h
240	3FFFh	FBFC10h	0FFFFFFFh	1BF244B0h
256	3FFFh	FBFC10h	0FFFFFFFh	1DCF32B0h
480	3FFFh	FBFC10h	0FFFFFFFh	37E436B0
512	3FFFh	FBFC10h	0FFFFFFFh	3B9E12B0h
960	3FFFh	FBFC10h	0FFFFFFFh	6FC81AB0h
1024	3FFFh	FBFC10h	0FFFFFFFh	773BD2B0h

7. PHYSICAL DIMENSION

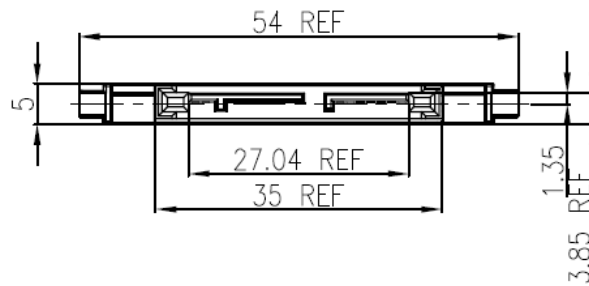
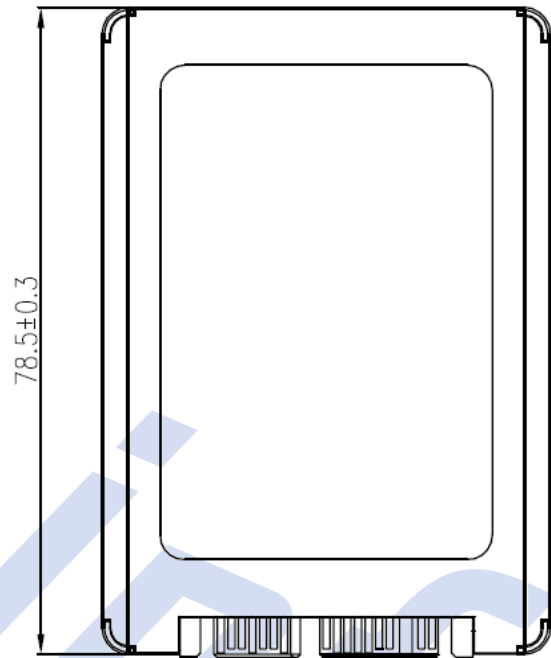


Dimension: 78.5mm(L) x 54mm(W) x 5.00mm(H)

TOP View



Bottom View



Side Vie

8. TERMINOLOGY



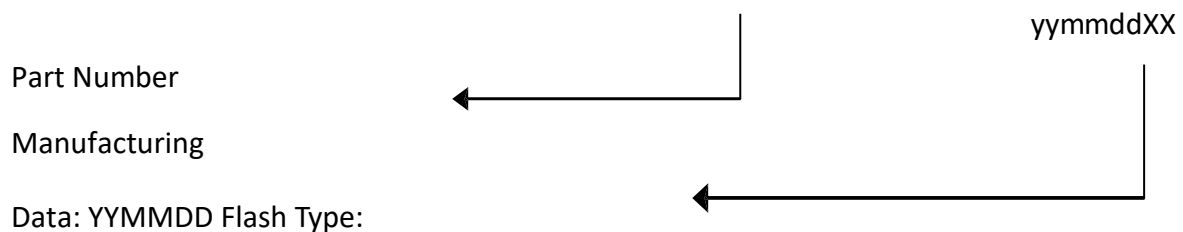
The following table is to list out the acronyms that have been applied throughout the document.

Term	Definitions
ATTO	Commercial performance benchmark application
DDR	Double data rate (SDRAM)
DIPM	Device initiated power management
HIPM	Host initiated power management
LBA	Logical block addressing
MB	Mega-byte
MTBF	Mean time between failures
NCQ	Native command queue
SATA	Serial advanced technology attachment
S.M.A.R.T.	Self-monitoring, analysis and reporting technology
SSD	Solid state disk

9. BARCODE DESCRIPTION



M 1 8 1 6 U K 5 1 2 G B K 2 U



10. PARTNUMBER DECODER



M18-16UKX⁸X⁹X¹⁰X¹¹X¹²X¹³X¹⁴X¹⁵X¹⁶X¹⁷

X ¹ X ² X ³	X ⁴ X ⁵	X ⁶ X ⁷	X ⁸ X ⁹ X ¹⁰ X ¹¹ X ¹²	X ¹³	X ¹⁴	X ¹⁵	X ¹⁶ X ¹⁷
M18	16	UK	008GB 016GB 032GB 064GB 128GB 256GB 512GB 001TB	C: SLC Standard (0°C ~ +70°C) I: SLC Industrial (-40°C ~ +85°C) K: MLC Standard (0°C ~ +70°C) M: MLC Industrial (-40°C ~ +85°C) P: pSLC Standard (0°C ~ +70°C) F: pSLC Industrial (-40°C ~ +85°C) A: 3D TLC Standard (0°C ~ +70°C) B: 3D TLC Industrial (-40°C ~ +85°C) V: 3D pSLC Standard (0°C ~ +70°C) W: 3D pSLC Industrial (-40°C ~ +85°C)	2	U	blank

